Abstract

METHODS AND APPARATUS FOR CHARACTERIZING BOARD TEST COVERAGE

Disclosed are methods and apparatus for characterizing board test coverage. In one method, potentially defective properties are enumerated for a board, without regard for how the potentially defective properties might be tested. For each potentially defective property enumerated, a property score is generated. Each property score is indicative of whether a test suite tests for a potentially defective property. Property scores are then combined in accordance with a weighting structure to characterize board test coverage for the test suite.

FIG. 1

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